

Search Notes**Application/Control No.**

10/648,172

Examiner

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Applicant(s)/Patent under Reexamination

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Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	706	6/30/2005	KCC
	712		
	719		
	720		
	723		
	724		
438	725	6/30/05	KCC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST key words search, USPAT, US- PGPUB, EPO, JPO, Derwent, IBM- TDB, inventor search.	6/30/2005	KCC